

NID1100

1.5 V to 5.5 V, 1 A, ideal diode with forward voltage blocking Rev. 3 — 26 August 2025 Product data sheet

1. General description

The NID1100 is a low forward-voltage drop ideal diode with forward and reverse voltage blocking. It can be used to replace rectifiers in low voltage systems unable to tolerate the high voltage drops of conventional Schottky diodes. The device operates over an input voltage range of 1.5 V to 5.5 V and can support up to 1 A continuous current. They can also be used in dual supply systems in an OR-ing configuration to switch the load seamlessly from one supply to the next.

The EN pin determines the operation mode of the NID1100. When EN is low, the NID1100 blocks voltages in both forward and reverse directions. When the enable input goes high, and the input voltage is higher than the output voltage, the NID1100 starts up in controlled manner limiting the inrush current. Once inrush is complete, the device regulates the voltage between the IN and OUT pins resulting in a forward voltage drop, V_{FWD}, approximately an order of magnitude smaller than similarly rated Schottky diodes. If at any time, the OUT voltage becomes higher than IN voltage, the NID1100 stops conducting with very low leakage currents.

The NID1100 also includes short circuit current limiting and over temperature shut down to provide robust protection against load fault conditions. The opendrain ST pin can be used to monitor the status of the NID1100. The ST pin pulls low when the device is disabled, in reverse voltage blocking state or in over temperature shut down.

A variety of power OR-ing configurations are supported for system flexibility:

- Two, or more, NID1100 devices
- · NID1100 and conventional Schottky diodes
- NID1100 and an external PMOS

The NID1100 is available in a standard SOT753 (SC-74A) package and is characterized for operation over a junction temperature range of –40 °C to 125 °C.

2. Features and benefits

- Input voltage range of 1.5 V to 5.5 V
- Low forward drop voltage: V_{FWD} = 120 mV (typ. at 3.6 V input and 1 A load current)
- · Reverse voltage blocking always
 - Low leakage current when V_{OUT} > V_{IN}
- Forward voltage blocking when disabled
- Low quiescent current
- · Enhanced load transient response
- · Controlled slew rate at startup
- Over temperature protection
- · Short circuit protection
- SOT753 (SC-74A) 5 pins plastic surface-mounted package
- Specified over T_i= -40 °C to +125 °C

3. Applications

- IoT systems
- · Gas meters, smart meters
- CO Detectors
- · Battery backup systems
- · USB powered devices

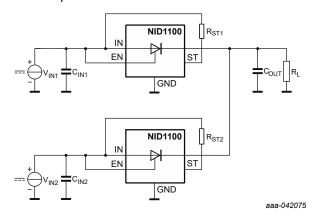


Fig. 1. Simplified application



1.5 V to 5.5 V, 1 A, ideal diode with forward voltage blocking

4. Ordering information

Table 1. Ordering information

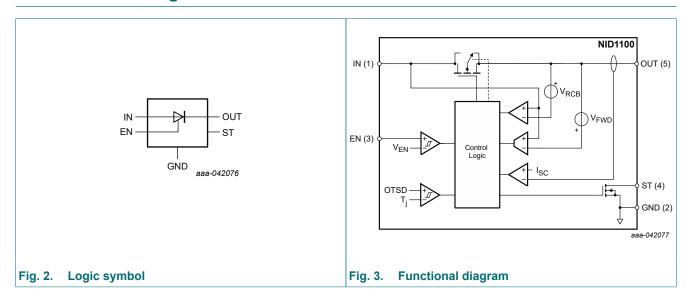
Type number	Package					
	Temperature range	Name	Description	Version		
NID1100GV	-40 °C to +125 °C	SC-74A	plastic surface-mounted package; 5 leads	SOT753		

5. Marking

Table 2. Marking code

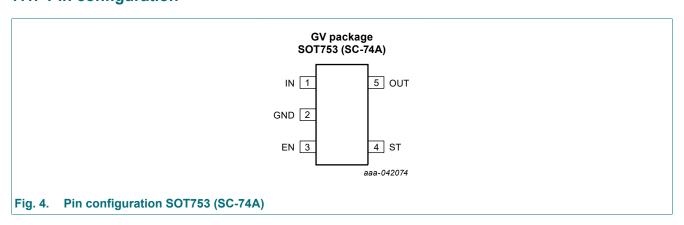
Type number	Marking code
NID1100GV	u2

6. Functional diagram



7. Pin configuration and description

7.1. Pin configuration



1.5 V to 5.5 V, 1 A, ideal diode with forward voltage blocking

7.2. Pin description

Table 3. Pin description

Symbol	Pin	I/O	Description			
IN	1	I	"Anode" connection of the ideal diode. Connect to a power supply. Bypass with a low ESR capacitance of at least 0.1 μ F.			
GND	2	GND	Ground (0 V)			
EN	3	I	Active high enable input to the IC. Connect to IN to permanently enable the device. Connect to GND to disable. Connect EN to an I/O to control it. Do not leave this pin floating.			
ST	4	0	Active Low status output. Pulls low during when device is disabled, in reverse voltage blocking state or in over temperature shut down. Pull up with a resistor to IN. Leave floating or connect to GND if not used.			
OUT	5	0	"Cathode" connection of the ideal diode. Connect to the load. Bypass with a low ESR capacitance of at least 0.33 μF_{\cdot}			

8. Specifications

8.1. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{IN}	input voltage		-0.3	6	V
V _{OUT}	output voltage		-0.3	6	V
V _{EN}	EN pin voltage		-0.3	6	V
V_{ST}	ST pin voltage		-0.3	6	V
I _{ST}	max current into status pin		-	1	mA
Tj	junction temperature		-40	125	°C
T _{stg}	storage temperature		-65	150	°C

8.2. ESD ratings

Table 5. ESD ratings

Symbol	Parameter	Conditions	Value	Unit
V -	electrostatic discharge	HBM: ANSI/ESDA/JEDEC JS-001 class 2	±2000	V
V _{ESD}	electrostatic discriarge	CDM: ANSI/ESDA/JEDEC JS-002 class C2a	±500	V

1.5 V to 5.5 V, 1 A, ideal diode with forward voltage blocking

8.3. Recommended operating conditions

Table 6. Recommended operating conditions

Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{IN}	input voltage		1.5	5.5	V
V _{OUT}	output Voltage		0	5.5	V
I _{OUT}	max continuous output	>2.0 V input	-	1	Α
	current	1.6 V to 1.9 V		0.5	Α
		1.5 V		50	mA
I _{OUT,SW}	maximum pulsed switch current	≤120 ms, 2% duty-cycle, V _{IN} = 3.3 V/5.0 V	-	1.5	А
V _{EN}	EN Pin voltage		0	5.5	V
I _{ST}	current into ST pin		0	0.5	mA

8.4. Recommended components

Table 7. Recommended components

Nominal component values, derating factors not included.

Symbol	Parameter	Min	Nom	Max	Unit
C _{IN}	capacitance on IN [1]	0.1	1	-	μF
C _{OUT}	capacitance on OUT [2][3]	0.33	0.47	-	μF

^[1] An input capacitor is required for proper operation.

8.5. Thermal information

Table 8. Thermal information

Thermal resistance according to JEDEC51-5 and -7

Symbol	Parameter	SOT753	Unit
$R_{\Theta JA}$	junction-to-ambient thermal resistance	206	°C/W
Ψ_{JT}	junction-to-top characterization parameter	111	°C/W

^[2] An output capacitor is required for proper operation.

^[3] See Section 10.4 for the detailed guidance on appropriately sizing the output capacitor.

1.5 V to 5.5 V, 1 A, ideal diode with forward voltage blocking

8.6. Electrical characteristics

Table 9. Static characteristics

 V_{IN} = 3.6 V, V_{EN} = 3.6 V, R_{ST} = 36.5 k Ω pull-up resistor to 3.6 V, C_{OUT} = 0.33 μF unless otherwise specified.

Symbol	Parameter	Conditions		$T_j = -$	25 °C	Unit	
				Min	Typ[1]	Max	
Input							
I _{IN,Q}	input quiescent current	$V_{EN} = V_{IN}$		-	562	725	nA
I _{IN,SD}	input shutdown current	EN = LO		-	108	250	nA
Pass FET							
V _{FWD}	forward voltage drop	V _{IN} = 1.5 V; I _O = 50 mA		-	55	97	mV
		V _{IN} = 3.6 V; I _O = 100 mA		-	36	75	
		V _{IN} = 3.6 V; I _O = 500 mA	[2]	-	62	100	mV
		V _{IN} = 3.6 V; I _O = 1000 mA	[2]	-	119	180	mV
		V _{IN} = 5.5 V; I _O = 100 mA		-	40	70	mV
Reverse (Current Blocking						
V _{RCBA}	RCB activation voltage V_{OUT} - V_{IN} ; ST pin goes from HI to LO		-	31	-	mV	
V _{RCBD}	RCB deactivation voltage	V _{IN} - V _{OUT} ; ST pin goes from LO to HI		-	41	-	mV
I _{IN,LKGE}	leakage current into IN,	V _{OUT} = 4 V	[2]	-220	331	615	nA
enabled		V _{OUT} = 5 V		-220	332	615	nA
I _{OUT,LKGE}	leakage current into OUT,	V _{OUT} = 4 V	[2]	-200	372	1200	nA
enabled	enabled	V _{OUT} = 5 V		-200	449	1200	nA
I _{IN,LKGD}	leakage current into IN,	V _{OUT} = 4 V; EN = LO	[2]	-500	-	500	nA
	disabled	V _{OUT} = 5 V; EN = LO		-500	-	500	nA
Enable in	put						
V _{EN,HI}	enable high threshold	ST goes LO to HI		1.2	-	-	V
V _{EN,LO}	enable low threshold	ST goes HI to LO		-	-	0.4	V
V _{EN,HYS}	enable hysteresis			-	45	-	mV
I _{EN,HI}	enable input current	V _{EN} = 3.6 V		-	-	50	nA
Status pii	1						
V _{OL,ST}	status low threshold	ST pin sinking 100 µA		-	-	0.3	V
I _{LKG,ST}	status pin leakage current	EN = 3.6 V		-75	-	75	nA
Short Circ	cuit Protection						
I _{LIM}	over current limit	$R_L = 100 \text{ m}\Omega$		-	2.8	-	Α
Over Tem	perature Shutdown						
T _{OTSD}	overtemperature shut down	T _j rising	[2]	170	175	-	°C
T _{OTHYS}	over temperature hysteresis	T _j falling	[2]	-	35	-	°C

All typical values are measured at T_{amb} = 25 °C. Not tested in production. Obtained by characterization.

1.5 V to 5.5 V, 1 A, ideal diode with forward voltage blocking

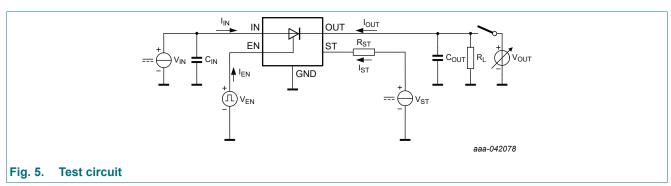
8.7. Dynamic characteristics

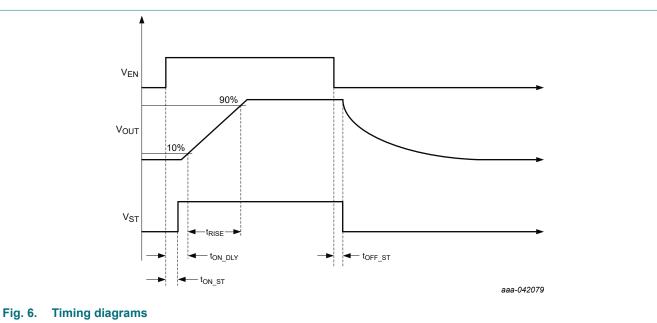
Table 10. Dynamic characteristics

 V_{IN} = 3.6 V, R_{ST} = 36.5 k Ω pull-up resistor to 3.6 V, C_{OUT} = 1 μ F, R_L = open unless otherwise specified.

Symbol	Parameter	Conditions			T _j = 25 °C		Unit
				Min	Тур	Max	
t _{ON,ST}	status ON delay time	EN = LO to HI step to ST = LO to HI step [1	1]	-	600	-	μs
t _{OFF,ST}	status OFF delay time	EN = HI to LO step to ST = HI to LO step [1	1]	-	45	-	μs
t _{ON,DLY}	turn-On delay time	V _{EN} = LO to HI step to V _{OUT} = 10 %		-	756	-	μs
t _{RISE}	rise time	V _{OUT} = 10 % to V _{OUT} = 90%		-	100	-	μs
t _{RCB}	reverse current blocking time	$V_{OUT} = V_{IN}$ -100 mV to V_{IN} +100mV step [1 to I_{IN} <1 mA	1]	-	8	-	μs
t _{LIM}	current limit response time	OUT shorted with 100 m Ω to I _{OUT} within [1 10% of I _{LIM}	1]	-	115	-	μs

[1] Not tested in production. Obtained by characterization.





1.5 V to 5.5 V, 1 A, ideal diode with forward voltage blocking

8.8. Typical characteristics graphs

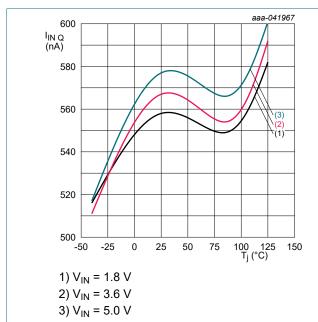
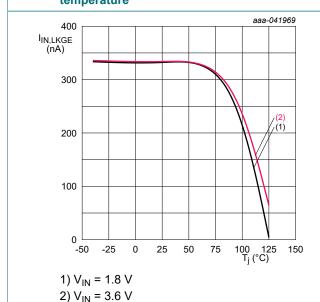
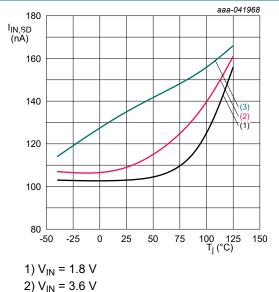


Fig. 7. Input quiescent current $(I_{IN,Q})$ versus junction temperature

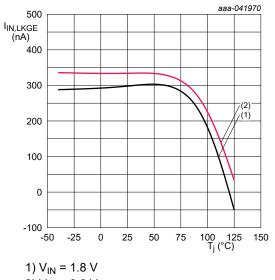


Input leakage current, enabled, (I_{IN,LKGE}) Fig. 9. junction temperature at V_{OUT} = 4 V



3) $V_{IN} = 5.0 \text{ V}$

Fig. 8. Input shutdown current (I_{IN,SD}) versus junction temperature



2) $V_{IN} = 3.6 \text{ V}$

Fig. 10. Input leakage current, enabled, (I_{IN,LKGE}) versus junction temperature at V_{OUT} = 5 V

7/26

1.5 V to 5.5 V, 1 A, ideal diode with forward voltage blocking

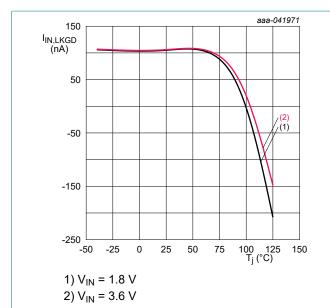
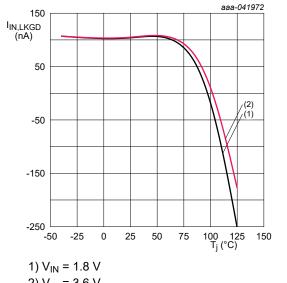


Fig. 11. Input leakage current, disabled, (I_{IN,LKGD}) versus | Fig. 12. Input leakage current, disabled, (I_{IN,LKGD}) versus junction temperature at V_{OUT} = 4 V



1)
$$V_{IN} = 1.6 \text{ V}$$

2) $V_{IN} = 3.6 \text{ V}$

junction temperature at $V_{OUT} = 5 V$

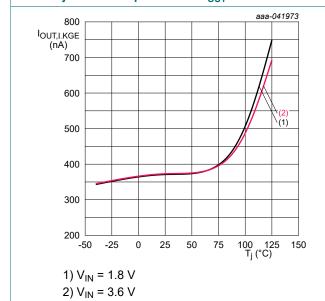
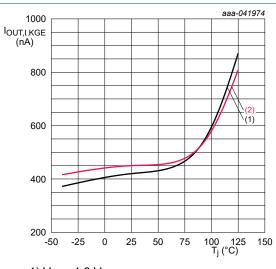


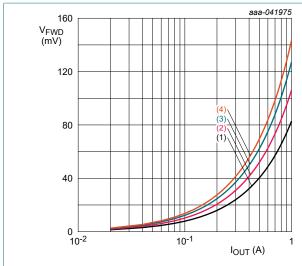
Fig. 13. Output leakage current, enabled, (I_{OUT,LKGE}) versus junction temperature at V_{OUT} = 4 V



1) $V_{IN} = 1.8 \text{ V}$ 2) $V_{IN} = 3.6 \text{ V}$

Fig. 14. Output leakage current, enabled, (I_{OUT,LKGE}) versus junction temperature at V_{OUT} = 5 V

1.5 V to 5.5 V, 1 A, ideal diode with forward voltage blocking



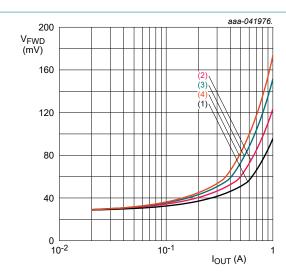
1)
$$T_i = -40 \, ^{\circ}C$$

2)
$$T_i = 25$$
 °C

3)
$$T_j = 85 \, ^{\circ}C$$

4)
$$T_j = 125 \, ^{\circ}\text{C}$$

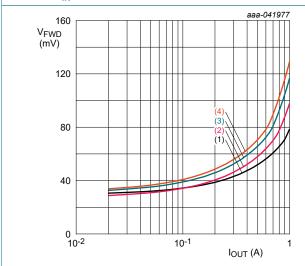




2)
$$T_i = 25 \, ^{\circ}C$$

3)
$$T_j = 85 \, ^{\circ}C$$

Fig. 16. Forward voltage drop versus load current at V_{IN} = 3.6 V



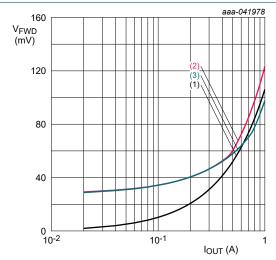
1)
$$T_i = -40 \, ^{\circ}C$$

2)
$$T_i = 25 \, ^{\circ}C$$

3)
$$T_i = 85 \,^{\circ}\text{C}$$

4)
$$T_j = 125 \, ^{\circ}C$$

Fig. 17. Forward voltage drop versus load current at V_{IN} = 5.0 V

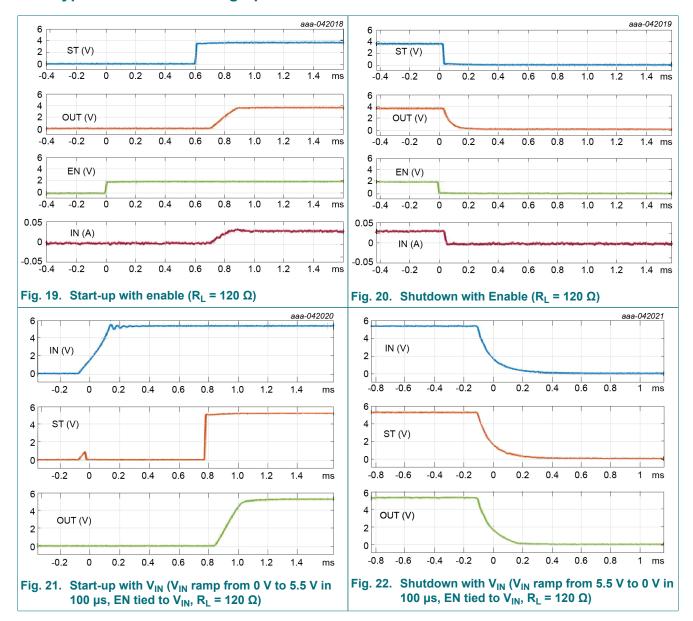


3)
$$V_{IN} = 5.0 V$$

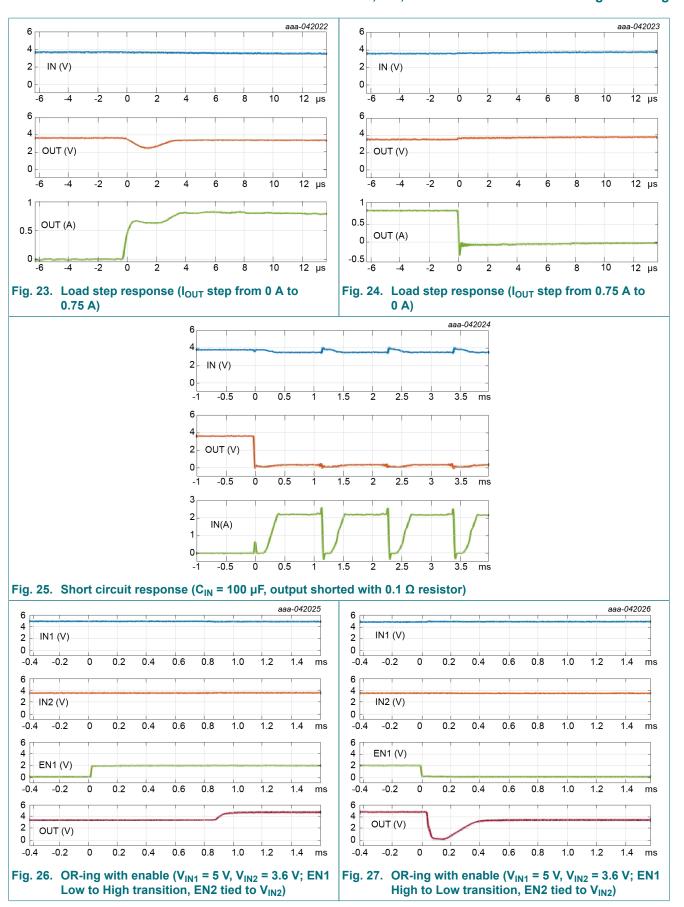
Fig. 18. Forward voltage drop versus load current at T_j = 25 $^{\circ}\text{C}$

1.5 V to 5.5 V, 1 A, ideal diode with forward voltage blocking

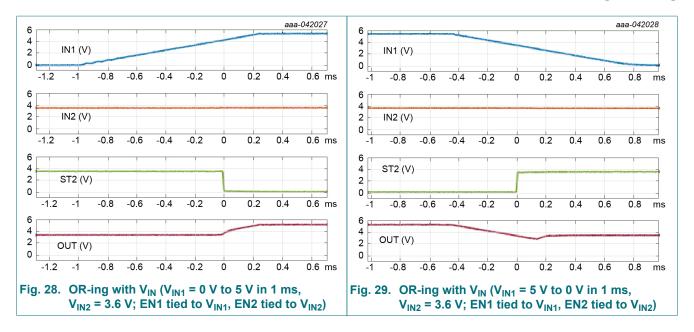
8.9. Typical characteristics graphs



1.5 V to 5.5 V, 1 A, ideal diode with forward voltage blocking



1.5 V to 5.5 V, 1 A, ideal diode with forward voltage blocking



1.5 V to 5.5 V, 1 A, ideal diode with forward voltage blocking

9. Functional Description

9.1. Overview

NID1100 is a low voltage ideal diode capable of blocking voltages in either direction. It has integrated protection features like Inrush Current Limit, Reverse Voltage Blocking, and Over Temperature Protection. It comes in a small 5-pin SOT753 (SC-74A) package.

9.2. Startup

The device starts when the voltage at either IN or OUT pins reach 1.5 V. Until then, there is insufficient voltage to power up the internal circuitry.

When V_{IN} exceeds 1.5 V (and $V_{OUT} < V_{IN}$), the device enters Power-On-Reset (POR). In this situation, the switch is held OFF and the body diode is oriented such that the anode is at OUT and cathode is at IN. If EN pin goes high, the IC starts charging the output capacitor with an internally controlled slew rate. Once the capacitor is fully charged, the internal FET's gate is controlled by a transconductance amplifier to maintain a constant difference between V_{IN} and V_{OUT} to emulate a diode. If EN is pulled low at any time, the FET is turned OFF.

9.3. Functional modes

Table 11 summaries the various functional modes of the NID1100 and the status of the diode and the ST pin in each mode.

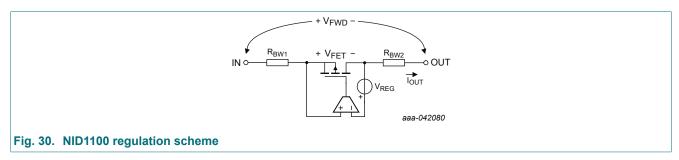
Table 11. Device functional modes (V_{IN} ≥ 1.5 V)

Table 11. Device fullcuonal	able 11. Device functional findes (VIN 2 1.3 V)						
Functional mode	EN pin	ST pin	Power device state				
OFF	LOW	LOW	Forward blocking				
ON	HIGH	High-Z	Forward conduction regulated V _{FWD}				
Reverse current blocking	X	LOW	Reverse blocking				
Output short	HIGH	High-Z	Forward conduction regulated I _{OUT}				
Thermal fault	HIGH	LOW	Reverse blocking				

The forward drop of the NID1100 depends on the input voltage and load current. Fig. 30 shows the internal block diagram of the NID1100 in forward regulation mode. Based on this figure, the drop seen between the IN and OUT pins (V_{FWD}) is given by the equation

$$V_{FWD} = I_{OUT} \times (R_{BW1} + R_{BW2}) + V_{FET}$$

where I_{OUT} is the load current, R_{BW1} and R_{BW2} are the bond wire impedances and V_{FET} is the voltage drop across the FET.



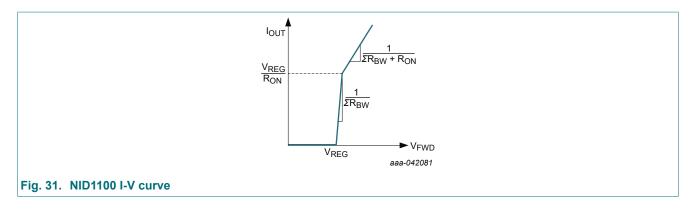
The voltage drop across the FET is regulated to V_{REG} until the load current increases to a point where

$$I_{OUT} = \frac{V_{REG}}{R_{ON}}$$

Where R_{ON} is the resistance of the FET.

The overall variation of the forward voltage incorporating all these effects is shown in Fig. 31.

1.5 V to 5.5 V, 1 A, ideal diode with forward voltage blocking



9.4. Reverse current blocking

Reverse Current Blocking (RCB) protection is always active, regardless of the state of EN. This protects the power supply from having to sink currents.

Two scenarios can activate the reverse current blocking functional mode.

- Output voltage starts rising and exceeds the input voltage (eg: OR-ing with two different voltage levels)
- Input voltage starts falling and goes below the output voltage (eg: loss of input power)

In either case, the NID1100 tries to maintain the forward drop between V_{IN} and V_{OUT} . As the V_{IN} - V_{OUT} differential starts reducing, the transconductance amplifier modulates the gate of the FET to increase its resistance to maintain the $V_{IN} - V_{OUT}$ differential. Once $V_{IN} \le V_{OUT}$, the transconductance amplifier turns off the pass transistor and prevents reverse currents. An internal comparator detects when $V_{IN} \le V_{OUT}$ - V_{RCBA} and flips the body diode polarity to ensure that the diode remains reverse biased.

When V_{IN} starts rising (or V_{OUT} starts falling) and V_{IN} exceeds $V_{OUT} + V_{RCBD}$, the diode polarity is flipped such that the anode is at IN and the pass FET starts conducting.

In case of an extremely fast transition from forward conduction to reverse bias, the comparator also acts to turn off the pass transistor before the transconductance amplifier has a chance to react.

9.5. Output overload and temperature protection

Unlike conventional diodes and other ideal diodes, the NID1100 is also protected from output short circuit and over temperature conditions. This is due to its unique feature of being able to block voltages in either direction.

When the output current exceeds I_{LIM} , the NID1100 limits the current through the device to I_{LIM} . It will stay in this current regulation mode until the output overload condition disappears or the junction temperature of the part exceeds T_{OTSD} .

Once an over temperature condition is detected, the NID1100 turns of the pass transistor. Once the NID1100 cools down such that $T_i < T_{OTSD} - T_{HYS}$, the part attempts restart in an inrush controlled manner.

1.5 V to 5.5 V, 1 A, ideal diode with forward voltage blocking

10. Application information

Note: Application implementation information in the following sections is not part of the Nexperia component specification. Nexperia's device users are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

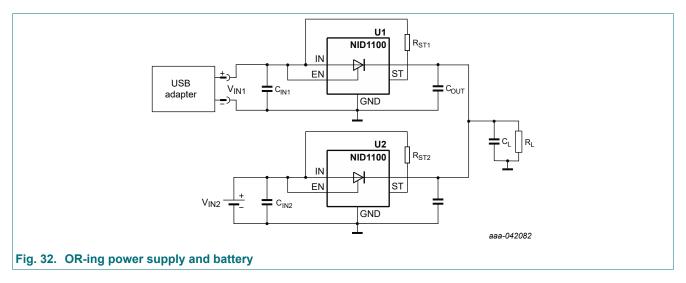
The NID1100 ideal diode is a versatile device suitable for high side power switching, protecting against reverse current conditions, OR-ing and simple power multiplexing. The following sections provide application examples to aid the design of products using NID1100.

10.1. Startup

10.1.1. n+1 OR-ing using ideal diodes

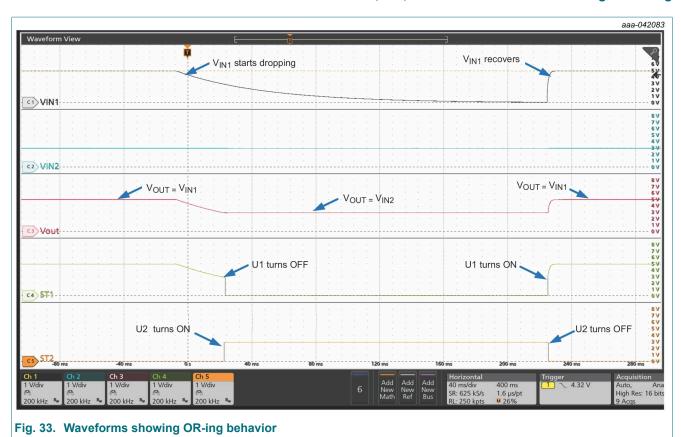
There is no specific limitation to the number of NID1100 ideal diodes used for power OR-ing. The example below illustrates a common two power supply scenario with smooth transitions between supplies.

Some devices operate from a fixed power supply such as a standard 5 V USB port output in normal conditions but must quickly transition to a 3 V battery backup when the power supply is disabled or unplugged. Using two NID1100 devices in a power OR-ing configuration, the downstream load remains uninterrupted when either the DC supply or the backup battery are disconnected.



The scope capture shows the output voltage (V_{OUT}) being initially powered by V_{IN1} at 5 V. When V_{IN1} is removed, V_{IN2} at 3.0 V powers V_{OUT} . When V_{IN1} is reconnected, V_{OUT} is once again powered by V_{IN1} . The ST pins of the NID1100's transition to indicate which ideal diode is supplying the load.

1.5 V to 5.5 V, 1 A, ideal diode with forward voltage blocking

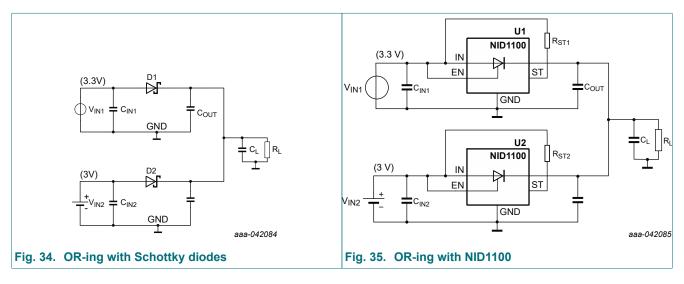


10.1.2. OR-ing similar supply voltages

Some applications may require the OR-ing of supplies with similar voltages (eg: $\underline{\text{Fig. 34}}$ and $\underline{\text{Fig. 35}}$). In these examples, the primary DC supply is 3.3 V with a 3 V battery backup. Consider the scenario where V_{IN1} , which is initially supplying the load, is removed and subsequently restored.

In case of the OR-ing scenario with Schottky diodes, as the two supplies differ by only 300 mV, when V_{IN1} is restored, there may not be enough forward voltage, V_F , across the diode in the V_{IN1} path to forward bias it. Thus, V_{IN2} will continue to deliver power to the load until the battery voltage depletes sufficiently wasting energy in the backup source.

In case of the OR-ing scenario with NID1100s, when V_{IN1} is restored, the reverse current blocking deactivation threshold, V_{RCBD} , is easily exceeded allowing the 3.3 V supply to carry the full load. As the OUT is approximately 300 mV above V_{IN2} , the 3 V supplied NID1100 becomes reverse biased and the battery drain is minimized.

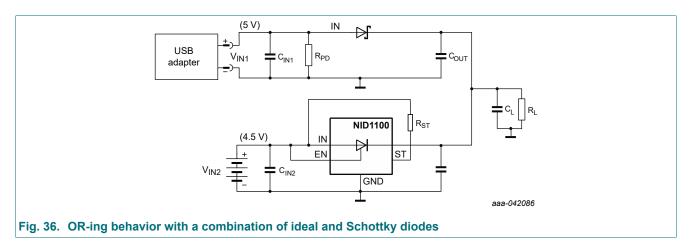


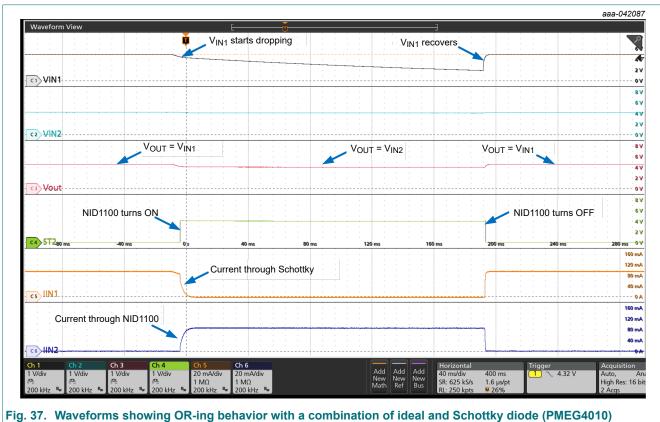
1.5 V to 5.5 V, 1 A, ideal diode with forward voltage blocking

10.1.3. n+1 OR-ing using ideal and conventional diodes

When voltage drops and electrical losses of one of two power sources is not of concern, a combination of ideal diodes and conventional diodes can be implemented as shown in Fig. 36. In this example the AC-DC adapter is the primary power source supplying 5 V to the system with three alkaline cells providing a 4.5 V backup. As stated in Section 8.6, consideration should be given to the V_F rating of the Schottky diode as well as worst case tolerances of the supply voltages to ensure seamless transitions.

A resistor, R_{PD} , connected to ground in the Schottky diode path is recommended to prevent diode reverse leakage during blocking conditions from charging C_{IN1} and raising V_{IN1} .

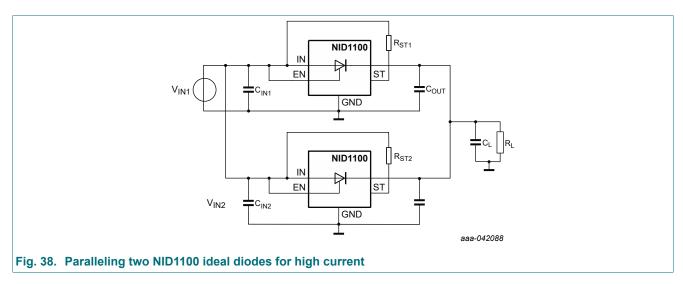


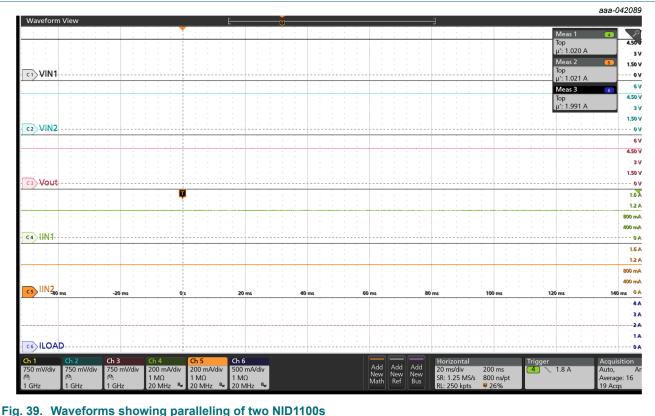


1.5 V to 5.5 V, 1 A, ideal diode with forward voltage blocking

10.1.4. Paralleling NID1100 for thermal and sustained high current considerations

As with using any power semiconductor component, thermal ratings must be observed to maintain device reliability. Refer to the <u>Section 8.5</u> table. System thermal analysis should be performed to ensure the device junction temperature, T_J, remains below 125 °C under all operating conditions. If analysis shows that using a single NID1100 would cause a thermal violation, two NID1100s can be paralleled to share the load current and lower internal power dissipation as shown in <u>Fig. 38</u>. <u>Fig. 39</u> shows two NID1100's supporting a combined 2 A load current with 1 A current flowing in each NID1100.

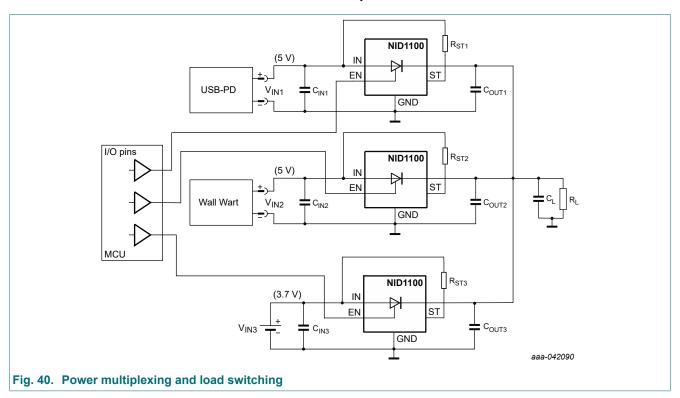




1.5 V to 5.5 V, 1 A, ideal diode with forward voltage blocking

10.1.5. Power multiplexing and load switching

Because the NID1100 has forward voltage blocking, it is possible to use a single device as a high side load switch with short circuit protection or multiple devices for power multiplexing. <u>Fig. 40</u> depicts an application example that can be used to switch between an USB-PD source, a wall wart and a Li-ion battery.



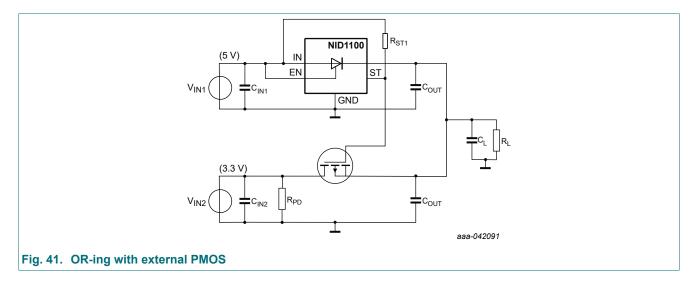
1.5 V to 5.5 V, 1 A, ideal diode with forward voltage blocking

10.1.6. OR-ing with discrete MOSFET

In this application, the EN pin of the NID1100 is always connected to V_{IN1} "enabling" the device. When both the 5 V and 3.3 V supplies are present, OUT is initially 5 V and the ST pin is high-Z with the R_{ST1} resistor pulled up to V_{IN1} , keeping the gate of the external PFET high.

- If V_{IN1} is quickly removed, the ST pin output will transition low, enhancing the external PMOS. The load is then supplied from V_{IN2}.
- If V_{IN1} is a slowly discharging battery, OUT will transition from being supplied by the NID1100 OUT pin to being supplied by the external PMOS when V_{IN1} decreases below V_{IN2} by V_{FWD(ext_PMOS)}.
- Conversely, if V_{IN1} is slowly recharged, OUT will be supplied from the PMOS until V_{IN1} + V_{REG} ≥ V_{IN2} + V_{RDSON(ext PMOS)}

Note: The supply to the NID1100 (V_{IN1}) should be the higher of the two supplies when both V_{IN1} and V_{IN2} are present. Fig. 42 shows the switchover performance between V_{IN1} and V_{IN2} . A resistor, R_{PD} , to ground is recommended to prevent any reverse leakage from charging the 3.3 V C_{IN2} capacitor and raising the V_{IN2} voltage in the event the 3.3 V supply is disconnected.



1.5 V to 5.5 V, 1 A, ideal diode with forward voltage blocking

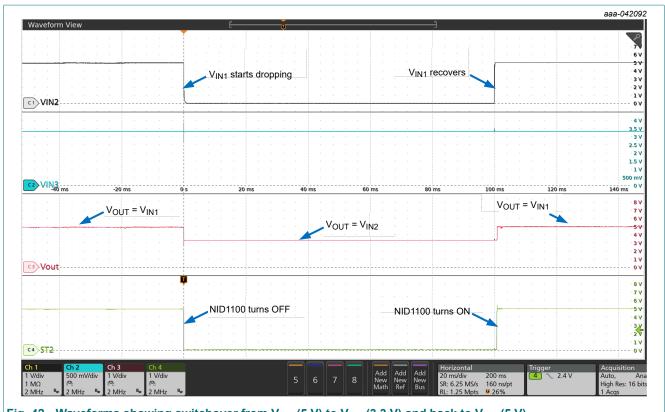


Fig. 42. Waveforms showing switchover from V_{IN1} (5 V) to V_{IN2} (3.3 V) and back to V_{IN1} (5 V)

10.2. Thermal characteristics and power dissipation

The junction temperature of a semiconductor device is determined by the internal power dissipation and its capacity to dissipate heat to the surrounding environment. The electronic equivalent is shown in <u>Fig. 43</u>.

From the diagram, the formula for calculating the junction temperature can be derived as follows:

$$T_i = P_{DIS} \times R_{th} + T_{amb}$$

Where T_j is the junction temperature, P_{DIS} is the power dissipation, R_{th} is the thermal resistance, and T_{amb} is the ambient temperature.

The internal power dissipation is given by:

$$P_{DIS} = I_{OUT} \times (V_{IN} - V_{OUT})$$

Where I_{OUT} is the output current, V_{IN} is the input voltage, and V_{OUT} is the output voltage.

It is a characteristic of semiconductor devices that power losses increase with rising temperatures. Operating the device above the specified maximum junction temperature of 125°C can lead to thermal runaway due to these increased losses, thereby reducing the device's lifespan or triggering thermal protection.

The aforementioned equations can be used to estimate the junction temperature for a given application. To verify the actual junction temperature, the specified Ψ_{JT} value can be used in conjunction with the measured top package temperature:

$$T_j = \Psi_{JT} \times P_{DIS} + T_{TOP}$$

where T_{TOP} is the top surface temperature of the package.

NID1100

All information provided in this document is subject to legal disclaimers.

© Nexperia B.V. 2025. All rights reserved

1.5 V to 5.5 V, 1 A, ideal diode with forward voltage blocking

10.3. Power supply recommendations

NID1100 is designed to operate with a V_{IN} range of 1.5 V to 5.5 V.

The V_{IN} power supply must be well regulated and placed as close to the device terminal as possible. The power supply must be able to withstand all transient load current steps.

In most cases, using an input capacitance (C_{IN}) of 0.1 + 1 μF is sufficient to prevent the supply voltage from drooping. In other cases where the power supply is slow to respond to a large transient current or large load current step, additional bulk capacitance is required on the input.

An effective capacitance of no less than $0.3 \mu F$, after applying voltage and temperature derating factors, is required on the OUT pin to ensure the stability of the control loop Gm amplifier.

10.4. Output capacitance considerations

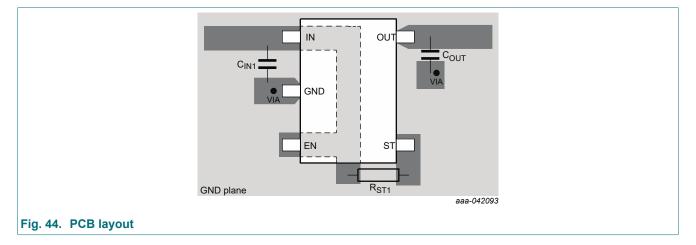
When selecting the output capacitor (C_{OUT}) for the NID1100, consider inrush current, thermal performance, startup behavior, and system stability. Internal validation showed stable operation with output capacitance up to 1000 μ F (1 mF).

Testing used hot-plug conditions at V_{IN} = 5.5 V, load current = 1 A, and C_{OUT} = 1 mF at an ambient temperature of 85 °C. The device completed over 1 million cycles with no degradation or abnormal behavior. This result confirms the robustness of the NID1100 under high output capacitance.

The NID1100 can support output capacitance above 1 mF. This allows flexibility for designs that require large bulk capacitance or load stabilization. However, the correct value of C_{OUT} depends on the system design and operating conditions. The designer must check inrush current, thermal limits, startup behavior, and stability before selecting a capacitor. While 1 mF is a validated safe value, higher values are acceptable at the designer's discretion.

10.5. PCB Layout

For best performance, all traces must be as short as possible. To be most effective, the input and output capacitors must be placed close to the device to minimize the effects that parasitic trace inductances may have on normal operation. Using wide traces for V_{IN} , V_{OUT} and GND helps minimize the parasitic electrical events.



1.5 V to 5.5 V, 1 A, ideal diode with forward voltage blocking

11. Package outline

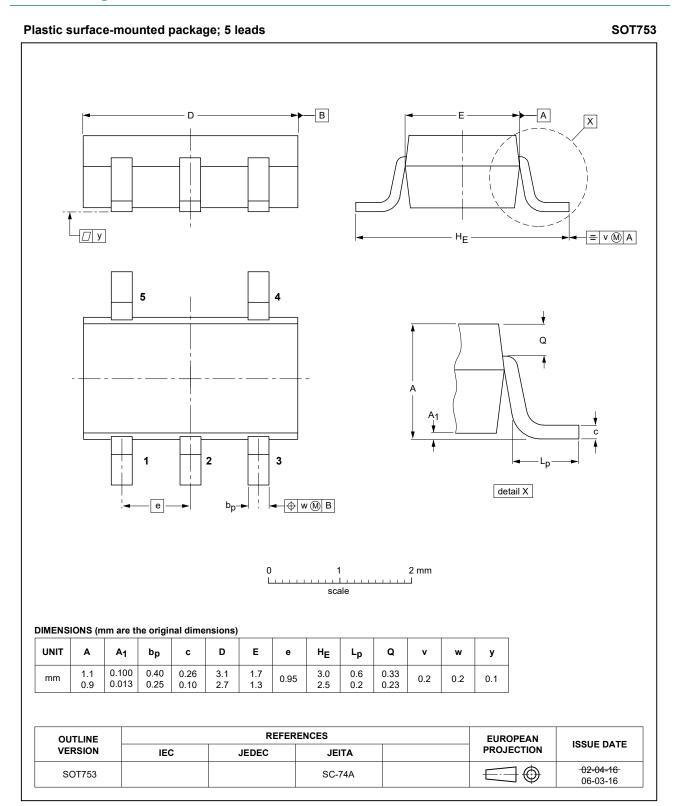


Fig. 45. Package outline SOT753 (SC-74A)

1.5 V to 5.5 V, 1 A, ideal diode with forward voltage blocking

12. Abbreviations

Table 12. Abbreviations

Acronym	Description		
CDM	Charged Device Model		
ESD	ElectroStatic Discharge		
FET	Field-Effect Transistor		
НВМ	Human Body Model		
IEC	International Electrotechnical Commission		
JEDEC	Joint Electron Device Engineering Council		
MOSFET	Metal-Oxide Semiconductor Field-Effect Transistor		
PCB	Printed Circuit Board		
PMOS	P-channel Metal-Oxide Semiconductor		

13. Revision history

Table 13. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes	
NID1100 v.3	20250826	Product data sheet	-	NID1100 v.2	
Modifications		 Editorial corrections Added new sections <u>Section 8.4</u>, <u>Section 10.3</u>, and <u>Section 10.4</u>. 			
NID1100 v.2	20250317	Product data sheet	-	NID1100 v.1	
Modifications		ction 9.3: Typo corrected in equation. . 40 moved to <u>Section 10.1.5</u> and <u>Section 10.2</u> updated.			
NID1100 v.1	20250120	Product data sheet	-	-	

1.5 V to 5.5 V, 1 A, ideal diode with forward voltage blocking

14. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
- The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the internet at https://www.nexperia.com.

Definitions

Draft — The document is a draft version only. The content is still under internal review and subject to formal approval, which may result in modifications or additions. Nexperia does not give any representations or warranties as to the accuracy or completeness of information included herein and shall have no liability for the consequences of use of such information.

Short data sheet — A short data sheet is an extract from a full data sheet with the same product type number(s) and title. A short data sheet is intended for quick reference only and should not be relied upon to contain detailed and full information. For detailed and full information see the relevant full data sheet, which is available on request via the local Nexperia sales office. In case of any inconsistency or conflict with the short data sheet, the full data sheet shall prevail.

Product specification — The information and data provided in a Product data sheet shall define the specification of the product as agreed between Nexperia and its customer, unless Nexperia and customer have explicitly agreed otherwise in writing. In no event however, shall an agreement be valid in which the Nexperia product is deemed to offer functions and qualities beyond those described in the Product data sheet.

Disclaimers

Limited warranty and liability — Information in this document is believed to be accurate and reliable. However, Nexperia does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information. Nexperia takes no responsibility for the content in this document if provided by an information source outside of Nexperia.

In no event shall Nexperia be liable for any indirect, incidental, punitive, special or consequential damages (including - without limitation - lost profits, lost savings, business interruption, costs related to the removal or replacement of any products or rework charges) whether or not such damages are based on tort (including negligence), warranty, breach of contract or any other legal theory.

Notwithstanding any damages that customer might incur for any reason whatsoever, Nexperia's aggregate and cumulative liability towards customer for the products described herein shall be limited in accordance with the Terms and conditions of commercial sale of Nexperia.

Right to make changes — Nexperia reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

Suitability for use — Nexperia products are not designed, authorized or warranted to be suitable for use in life support, life-critical or safety-critical systems or equipment, nor in applications where failure or malfunction of an Nexperia product can reasonably be expected to result in personal

injury, death or severe property or environmental damage. Nexperia and its suppliers accept no liability for inclusion and/or use of Nexperia products in such equipment or applications and therefore such inclusion and/or use is at the customer's own risk.

Quick reference data — The Quick reference data is an extract of the product data given in the Limiting values and Characteristics sections of this document, and as such is not complete, exhaustive or legally binding.

Applications — Applications that are described herein for any of these products are for illustrative purposes only. Nexperia makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

Customers are responsible for the design and operation of their applications and products using Nexperia products, and Nexperia accepts no liability for any assistance with applications or customer product design. It is customer's sole responsibility to determine whether the Nexperia product is suitable and fit for the customer's applications and products planned, as well as for the planned application and use of customer's third party customer(s). Customers should provide appropriate design and operating safeguards to minimize the risks associated with their applications and products.

Nexperia does not accept any liability related to any default, damage, costs or problem which is based on any weakness or default in the customer's applications or products, or the application or use by customer's third party customer(s). Customer is responsible for doing all necessary testing for the customer's applications and products using Nexperia products in order to avoid a default of the applications and the products or of the application or use by customer's third party customer(s). Nexperia does not accept any liability in this respect.

Limiting values — Stress above one or more limiting values (as defined in the Absolute Maximum Ratings System of IEC 60134) will cause permanent damage to the device. Limiting values are stress ratings only and (proper) operation of the device at these or any other conditions above those given in the Recommended operating conditions section (if present) or the Characteristics sections of this document is not warranted. Constant or repeated exposure to limiting values will permanently and irreversibly affect the quality and reliability of the device.

Terms and conditions of commercial sale — Nexperia products are sold subject to the general terms and conditions of commercial sale, as published at http://www.nexperia.com/profile/terms, unless otherwise agreed in a valid written individual agreement. In case an individual agreement is concluded only the terms and conditions of the respective agreement shall apply. Nexperia hereby expressly objects to applying the customer's general terms and conditions with regard to the purchase of Nexperia products by customer.

No offer to sell or license — Nothing in this document may be interpreted or construed as an offer to sell products that is open for acceptance or the grant, conveyance or implication of any license under any copyrights, patents or other industrial or intellectual property rights.

Export control — This document as well as the item(s) described herein may be subject to export control regulations. Export might require a prior authorization from competent authorities.

Non-automotive qualified products — Unless this data sheet expressly states that this specific Nexperia product is automotive qualified, the product is not suitable for automotive use. It is neither qualified nor tested in accordance with automotive testing or application requirements. Nexperia accepts no liability for inclusion and/or use of non-automotive qualified products in automotive equipment or applications.

In the event that customer uses the product for design-in and use in automotive applications to automotive specifications and standards, customer (a) shall use the product without Nexperia's warranty of the product for such automotive applications, use and specifications, and (b) whenever customer uses the product for automotive applications beyond Nexperia's specifications such use shall be solely at customer's own risk, and (c) customer fully indemnifies Nexperia for any liability, damages or failed product claims resulting from customer design and use of the product for automotive applications beyond Nexperia's standard warranty and Nexperia's product specifications.

Translations — A non-English (translated) version of a document is for reference only. The English version shall prevail in case of any discrepancy between the translated and English versions.

Trademarks

Notice: All referenced brands, product names, service names and trademarks are the property of their respective owners.

NID1100

All information provided in this document is subject to legal disclaimers.

© Nexperia B.V. 2025. All rights reserved

1.5 V to 5.5 V, 1 A, ideal diode with forward voltage blocking

For more information, please visit: http://www.nexperia.com For sales office addresses, please send an email to: salesaddresses@nexperia.com Date of release: 26 August 2025

Contents

1. General description	1
2. Features and benefits	1
3. Applications	
4. Ordering information	
5. Marking	
6. Functional diagram	2
7. Pin configuration and description	2
7.1. Pin configuration	
7.2. Pin description	
8. Specifications	3
8.1. Limiting values	3
8.2. ESD ratings	3
8.3. Recommended operating conditions	
8.4. Recommended components	4
8.5. Thermal information	4
8.6. Electrical characteristics	5
8.7. Dynamic characteristics	6
8.8. Typical characteristics graphs	7
8.9. Typical characteristics graphs	
9. Functional Description	13
9.1. Overview	13
9.2. Startup	13
9.3. Functional modes	13
9.4. Reverse current blocking	14
9.5. Output overload and temperature protection	
10. Application information	15
10.1. Startup	15
10.1.1. n+1 OR-ing using ideal diodes	15
10.1.2. OR-ing similar supply voltages	16
10.1.3. n+1 OR-ing using ideal and conventional diodes	17
10.1.4. Paralleling NID1100 for thermal and sustained high current considerations	18
10.1.5. Power multiplexing and load switching	
10.1.6. OR-ing with discrete MOSFET	
10.2. Thermal characteristics and power dissipation	
10.3. Power supply recommendations	
10.4. Output capacitance considerations	
10.5. PCB Layout	
11. Package outline	
12. Abbreviations	
13. Revision history	
14. Legal information	

© Nexperia B.V. 2025. All rights reserved

NID1100

All information provided in this document is subject to legal disclaimers.